

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/785,122	HALL ET AL.
	Examiner	Art Unit
	José R. Díaz	2815

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	783	4/23/2006	JRD
257	784	4/23/2006	JRD
257	787	4/23/2006	JRD